

$\mathbf{SuperFET}^{\scriptscriptstyle\mathsf{TM}}$

FCB11N60 600V N-Channel MOSFET

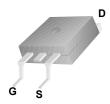
Features

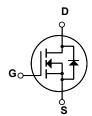
- 650V @T_J = 150°C
- Typ. $R_{DS(on)} = 0.32\Omega$
- Ultra low gate charge (typ. Q_g = 40nC)
- Low effective output capacitance (typ. Coss.eff = 95pF)
- · 100% avalanche tested

Description

SuperFETTM is, Farichild's proprietary, new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFET is very suitable for various AC/DC power conversion in switching mode operation for system miniaturization and higher efficiency.





Absolute Maximum Ratings

Symbol			FCB11N60	Unit
V _{DSS}			600	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		11 7	A A
I _{DM}	Drain Current - Pulsed	(Note 1)	33	А
V _{GSS}	Gate-Source voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		340	mJ
I _{AR}	Avalanche Current (Note 1)		11	А
E _{AR}	Repetitive Avalanche Energy (Note 1)		12.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation (T _C = 25°C) - Derate above 2	25°C	125 1.0	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature R	ange	-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FCB11N60	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.0	°C/W
R _{θJA} *	Thermal Resistance, Junction-to-Ambient*	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity	
FCB11N60	FCB11N60	D ² -PAK	330mm	24m	800	

Electrical Characteristics T_C = 25°C unless otherwise noted

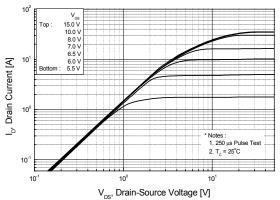
Symbol	Parameter	Conditions	Min	Тур	Max	Units
Off Charac	teristics			ı		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V$, $I_D = 250\mu A$, $T_J = 25^{\circ}C$	600			V
		V _{GS} = 0V, I _D = 250μA, T _J = 150°C		650		V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.6		V/°C
BV _{DS}	Drain-Source Avalanche Breakdown Voltage	V _{GS} = 0V, I _D = 11A		700		V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600V, V _{GS} = 0V V _{DS} = 480V, T _C = 125°C			1 10	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V	-		-100	nA
On Charac	teristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 5.5A		0.32	0.38	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40V, I _D = 5.5A (Note 4)	-	9.7		S
Dynamic C	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		1148	1490	pF
C _{oss}	Output Capacitance	f = 1.0MHz		671	870	pF
C _{rss}	Reverse Transfer Capacitance		1	63		pF
C _{oss}	Output Capacitance	$V_{DS} = 480V, V_{GS} = 0V, f = 1.0MHz$		35		pF
Coss eff.	Effective Output Capacitance	V_{DS} = 0V to 400V, V_{GS} = 0V	-	95		pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 300V, I _D = 11A		34	80	ns
t _r	Turn-On Rise Time	$R_G = 25\Omega$		98	205	ns
$t_{d(off)}$	Turn-Off Delay Time			119	250	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		56	120	ns
Qg	Total Gate Charge	V _{DS} = 480V, I _D = 11A	-	40	52	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10V	-	7.2		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		21		nC
Drain-Sour	rce Diode Characteristics and Maximur	n Ratings			_	
I _S	Maximum Continuous Drain-Source Dio	de Forward Current			11	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	orward Current	-		33	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 11A	-		1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 11A	1	390		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note 4)		5.7		μС

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} = 5.51A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 3. I $_{SD}$ \leq 11A, di/dt \leq 200A/ μ s, V_{DD} \leq BV $_{DSS}$, Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \ \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics



Drain Current and Gate Voltage

os, Jan. Coulos Vinago [1]

Figure 3. On-Resistance Variation vs.

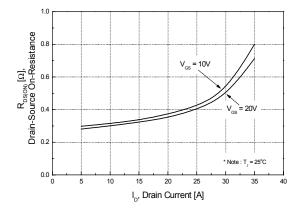


Figure 2. Transfer Characteristics

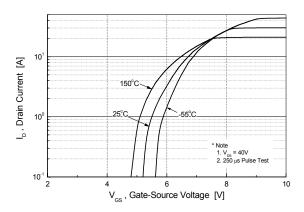


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

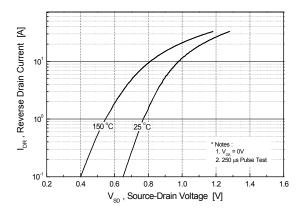


Figure 5. Capacitance Characteristics

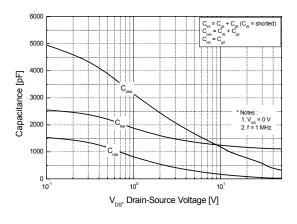
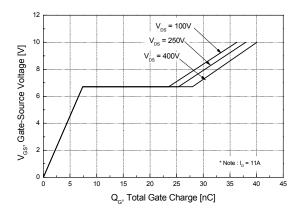


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

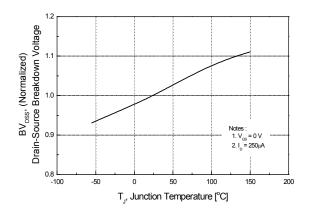


Figure 8. On-Resistance Variation vs. Temperature

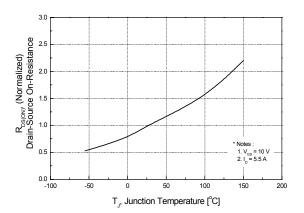


Figure 9. Maximum Safe Operating Area

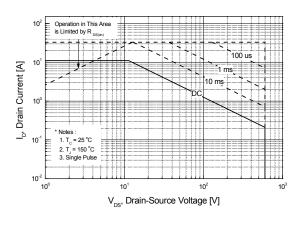


Figure 10. Maximum Drain Current vs. Case Temperature

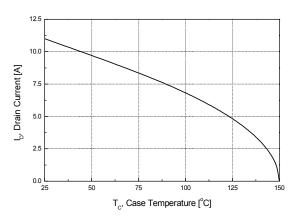
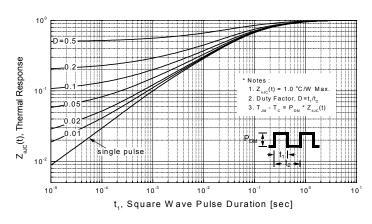
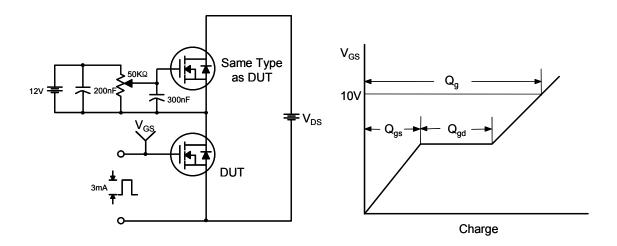


Figure 11. Transient Thermal Response Curve

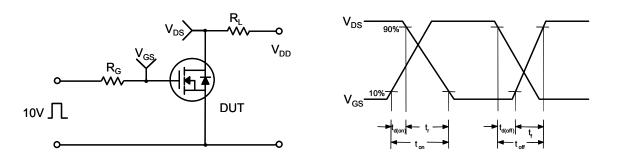


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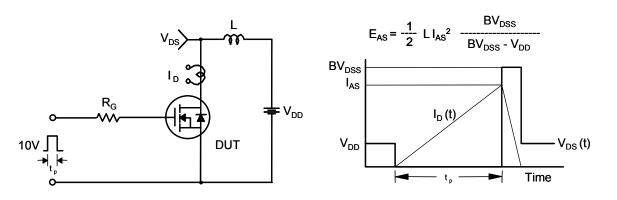
Gate Charge Test Circuit & Waveform



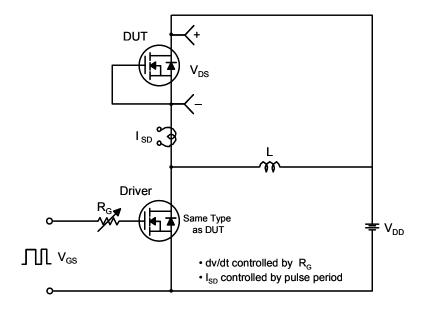
Resistive Switching Test Circuit & Waveforms

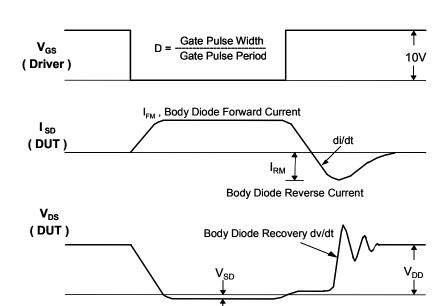


Unclamped Inductive Switching Test Circuit & Waveforms



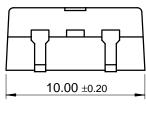
Peak Diode Recovery dv/dt Test Circuit & Waveforms

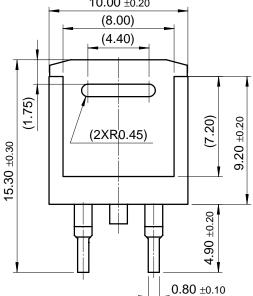




Body Diode Forward Voltage Drop

Mechanical Dimensions D²-PAK 4.50 ±0.20 9.90 ±0.20 (0.40) $1.30^{\,+0.10}_{\,-0.05}$ 1.20 ±0.20 9.20 ±0.20 2.00 ± 0.10 1.40 ± 0.20 15.30 ± 0.30 0.10 ±0.15 .54 ±0.30 2.40 ± 0.20 4.90 ±0.20 (0.75)0.80 ±0.10 1.27 ± 0.10 $0.50^{\,+0.10}_{\,-0.05}$ 2.54 TYP 2.54 TYP 10.00 ±0.20 (8.00)(4.40)





Dimensions in Millimeters

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FCB11N60

600V N-Channel SuperFET

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General description

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Product status/pricing/packaging

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Product	Product status	Pb-free Status	Pricing*	Package type	Leads	Packing method	Package Marking Convention**
FCB11N60TM	Full Production	Full Production	\$2.62	TO-263(D2PAK)	2	TAPE REEL	Line 1: \$Y (Fairchild logo) & Z (Asm. Plant Code) &E& 3 (3-Digit Date Code) Line 2: FCB Line 3: 11N60

^{*} Fairchild 1,000 piece Budgetary Pricing

^{**} A sample button will appear if the part is available through Fairchild's on-line samples program. If there is no sample button, please contact a <u>Fairchild distributor</u> to obtain samples



Indicates product with Pb-free second-level interconnect. For more information click here.

Package marking information for product FCB11N60 is available. Click here for more information.

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Qualification Support

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Product
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